

## MM54C173/MM74C173 TRI-STATE® Quad D Flip-Flop

### General Description

The MM54C173/MM74C173 TRI-STATE quad D flip-flop is a monolithic complementary MOS (CMOS) integrated circuit constructed with N- and P-channel enhancement transistors. The four D-type flip-flops operate synchronously from a common clock. The TRI-STATE output allows the device to be used in bus-organized systems.

The outputs are placed in the TRI-STATE mode when either of the two output disable pins are in the logic "1" level. The input disable allows the flip-flops to remain in their present states without disrupting the clock. If either of the two input disables are taken to a logic "1" level, the Q outputs are fed back to the inputs and in this manner the flip-flops do not change state.

Clearing is enabled by taking the input to a logic "1" level. Clocking occurs on the positive-going transition.

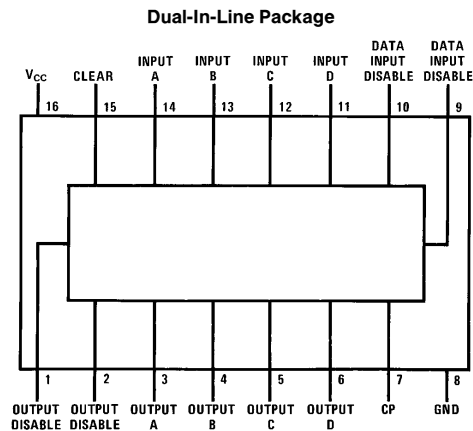
### Features

- Supply voltage range 3V to 15V
- Tenth power TTL compatible Drive 2 LPTTL loads
- High noise immunity 0.45 V<sub>CC</sub> (typ.)
- Low power
- Medium speed operation
- High impedance TRI-STATE
- Input disable without gating the clock

### Applications

- Automotive
- Data terminals
- Instrumentation
- Medical electronics
- Alarm systems
- Industrial electronics
- Remote metering
- Computers

### Connection Diagram



TL/F/5898-2

Top View

Order Number MM54C173 or MM74C173

### Truth Table

(Both Output Disables Low)

$t_n$		$t_{n+1}$
Data Input Disable	Data Input	Output
Logic "1" on One or Both Inputs	X	$Q_n$
Logic "0" on Both Inputs	1	1
Logic "0" on Both Inputs	0	0

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## Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Voltage at Any Pin	-0.3V to $V_{CC} + 0.3V$
Operating Temperature Range	
MM54C173	-55°C to +125°C
MM74C173	-40°C to +85°C
Storage Temperature Range	-65°C to +150°C

Maximum $V_{CC}$ Voltage	18V
Power Dissipation ( $P_D$ )	
Dual-In-Line	700 mW
Small Outline	500 mW
Operating $V_{CC}$ Range	3V to 15V
Lead Temperature (Soldering, 10 seconds)	260°C

## DC Electrical Characteristics Min/Max limits apply across temperature range unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>CMOS TO CMOS</b>						
$V_{IN(1)}$	Logical "1" Input Voltage	$V_{CC} = 5V$ $V_{CC} = 10V$	3.5 8.0			V V
$V_{IN(0)}$	Logical "0" Input Voltage	$V_{CC} = 5V$ $V_{CC} = 10V$			1.5 2.0	V V
$V_{OUT(1)}$	Logical "1" Output Voltage	$V_{CC} = 5V$ $V_{CC} = 10V$	4.5 9.0			V V
$V_{OUT(0)}$	Logical "0" Output Voltage	$V_{CC} = 5V$ $V_{CC} = 10V$			0.5 1.0	V V
$I_{IN(1)}$	Logical "1" Input Current	$V_{CC} = 15V$		0.005	1.0	$\mu A$
$I_{IN(0)}$	Logical "0" Input Current		-1.0	0.005		$\mu A$
$I_{OZ}$	Output Current in High Impedance State	$V_{CC} = 15V, V_O = 15V$ $V_{CC} = 15V, V_O = 0V$	-1.0	0.001 0.001	1.0	$\mu A$ $\mu A$
$I_{CC}$	Supply Current	$V_{CC} = 15V$		0.05	300	mA

## LOW POWER TTL/CMOS INTERFACE

$V_{IN(1)}$	Logical "1" Input Voltage	54C, $V_{CC} = 4.5V$ 74C, $V_{CC} = 4.5V$	$V_{CC} - 1.5$ $V_{CC} - 1.5$			V V
$V_{IN(0)}$	Logical "0" Input Voltage	54C, $V_{CC} = 4.5V$ 74C, $V_{CC} = 4.75V$			0.8 0.8	V V
$V_{OUT(1)}$	Logical "1" Output Voltage	54C, $V_{CC} = 4.5V, I_O = -360 \mu A$ 74C, $V_{CC} = 4.75V, I_O = -360 \mu A$	2.4 2.4			V V
$V_{OUT(0)}$	Logical "0" Output Voltage	54C, $V_{CC} = 4.5V, I_O = 360 \mu A$ 74C, $V_{CC} = 4.75V, I_O = 360 \mu A$			0.4 0.4	V V
$t_{pd0}, t_{pd1}$	Propagation Delay Time to a Logical "0" or Logical "1" from Clock	$V_{CC} = 5V, C_L = 50 pF,$ $T_A = 25^\circ C$		500		ns

## OUTPUT DRIVE (See 54C/74C Family Characteristics Data Sheet) (Short Circuit Current)

$I_{SOURCE}$	Output Source Current	$V_{CC} = 5V, V_{IN(0)} = 0V$ $T_A = 25^\circ C, V_{OUT} = 0V$	-1.75			mA
$I_{SOURCE}$	Output Source Current	$V_{CC} = 10V, V_{IN(0)} = 0V$ $T_A = 25^\circ C, V_{OUT} = 0V$	-8.0			mA
$I_{SINK}$	Output Sink Current	$V_{CC} = 5V, V_{IN(1)} = 5V$ $T_A = 25^\circ C, V_{OUT} = V_{CC}$	1.75			mA
$I_{SINK}$	Output Sink Current	$V_{CC} = 10V, V_{IN(1)} = 10V$ $T_A = 25^\circ C, V_{OUT} = V_{CC}$	8.0			mA

**Note 1:** "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

## AC Electrical Characteristics\* $T_A = 25^\circ\text{C}$ , $C_L = 50\text{ pF}$ , unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$t_{pd0}$ , $t_{pd1}$	Propagation Delay Time to a Logical "0" or Logical "1" from Clock to Output	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		220 80	400 200	ns ns
$t_S$	Input Data Set-up Time	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		40 15	80 30	ns ns
$t_H$	Input Data Hold Time	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		0 0	0 0	ns ns
$t_S$	Input Disable Set-up Time, $t_{S\text{ DISS}}$	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		100 35	200 70	ns ns
$t_H$	Input Disable Hold Time, $t_{H\text{ DISS}}$	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		0 0	0 0	ns ns
$t_{1H}$ , $t_{0H}$	Delay from Output Disable to High Impedance State (from Logical "1" or Logical "0" Level)	$V_{CC} = 5\text{V}$ , $R_L = 10\text{k}$ $V_{CC} = 10\text{V}$ , $R_L = 10\text{k}$		170 70	340 140	ns ns
$t_{H1}$	Delay from Output Disable to Logical "1" Level (from High Impedance State)	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		170 70	340 140	ns ns
$t_{H0}$	Delay from Output Disable to Logical "0" Level (from High Impedance State)	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		170 70	340 140	ns ns
$t_{pd0}$ , $t_{pd1}$	Propagation Delay from Clear to Output	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		240 90	490 180	ns ns
$f_{\text{MAX}}$	Maximum Clock Frequency	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$	3 7.0	4 12		MHz MHz
$t_W$	Minimum Clear Pulse Width	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$		150 70		ns ns
$t_r$ , $t_f$	Maximum Clock Rise and Fall Time	$V_{CC} = 5\text{V}$ $V_{CC} = 10\text{V}$	10 5			$\mu\text{s}$ $\mu\text{s}$
$C_{\text{IN}}$	Input Capacitance	(Note 2)		5		pF
$C_{\text{PD}}$	Power Dissipation Capacitance	(Note 3)				

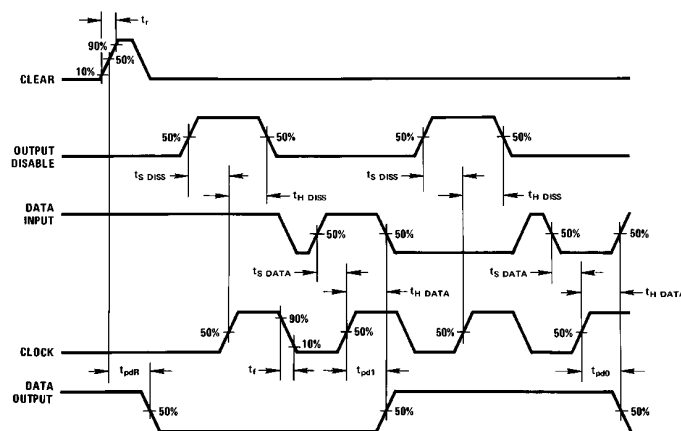
\*AC Parameters are guaranteed by DC correlated testing.

**Note 1:** "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

**Note 2:** Capacitance is guaranteed by periodic testing.

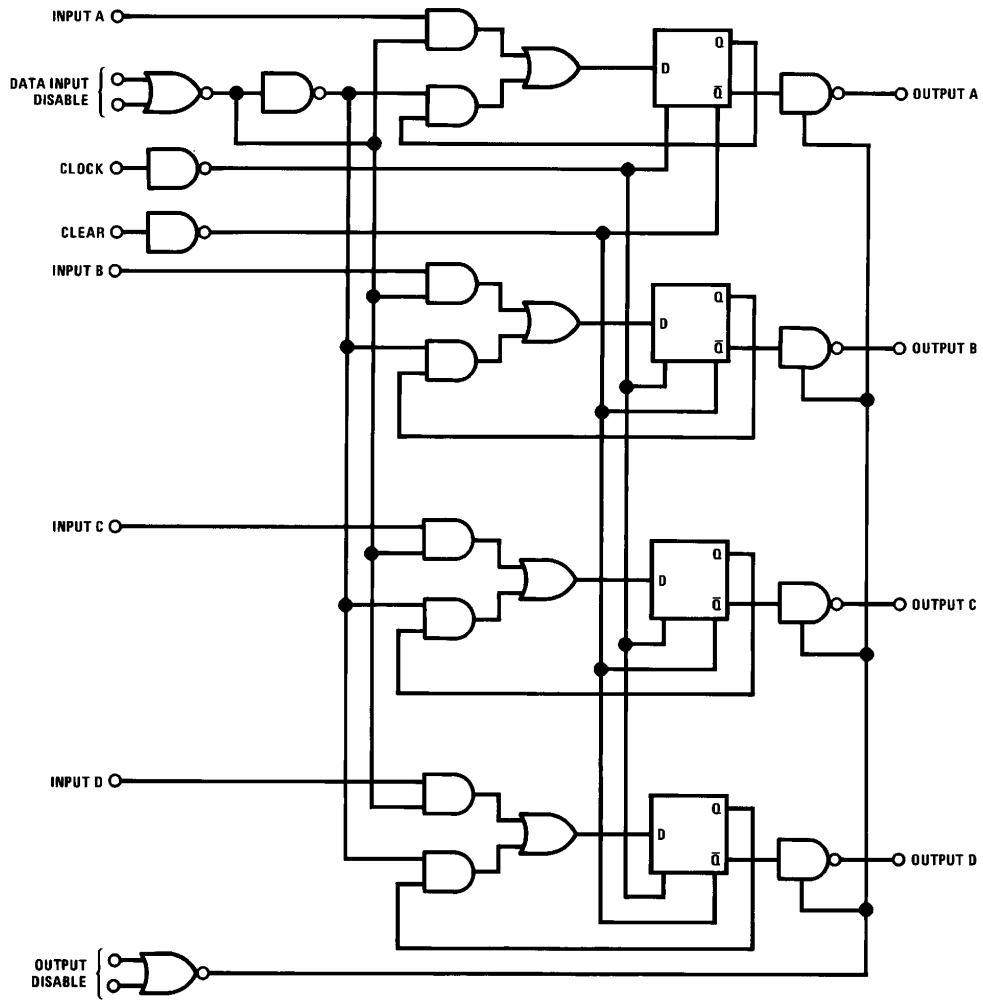
**Note 3:**  $C_{\text{PD}}$  determines the no load AC power consumption of any CMOS device. For complete explanation see 54C/74C Family Characteristics application note AN-90.

## Switching Time Waveforms



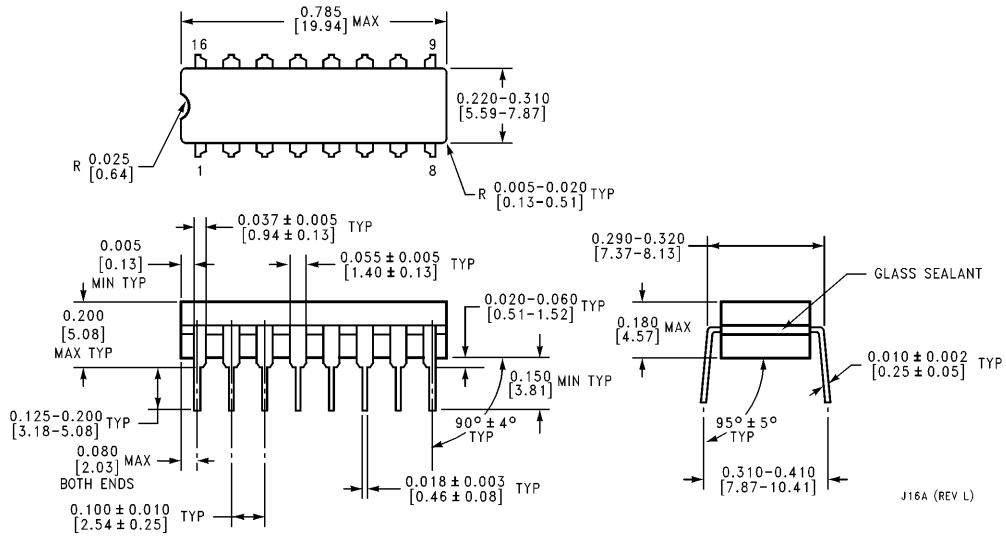
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# Logic Diagram



TL/F/5898-1

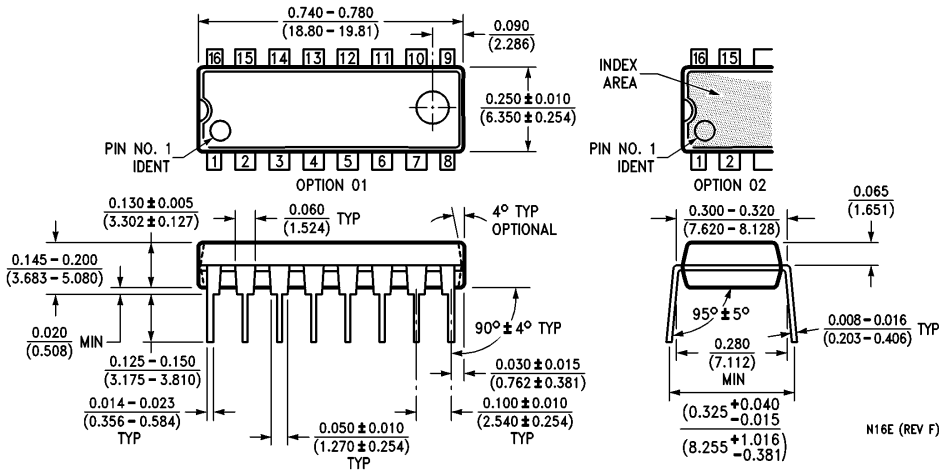
**Physical Dimensions** inches (millimeters)



**Ceramic Dual-In-Line Package (J)**  
**Order Number MM54C173J or MM74C173J**  
**NS Package Number J16A**

J16A (REV L)

**Physical Dimensions** inches (millimeters) (Continued)



**Molded Dual-In-Line Package (N)**  
**Order Number MM54C173N or MM74C173N**  
**NS Package Number N16E**

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